

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/021,495	SONY
Examiner	Art Unit	
Annan Q. Shang	2617	

Search Notes



Application/Control No.

10/021,495

Examiner

Annan Q. Shang

**Applicant(s)/Patent under
Reexamination**

SONY

Art Unit

2617

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)